Sear	earch Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/722,568	BAE, WON-YOUL	
Examiner	Art Unit	
Brian E. Miller	2627	

SEARCHED				
Class	Subclass	Date	Examiner	
720	616,610			
720	627,630			
720	631			
360	99.02			
360	99.03	7/21/2006	ВЕМ	
updated	as above	1/19/2007	ВЕМ	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST Search	6/23/2006	BEM	
PLUS Search	7/21/2006	вем	
EAST update Search (enclosed)	1/19/2007	ВЕМ	